



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10750568</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>NGUYEN ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	64	11/01/2006	HK
307	150	11/01/2006	HK

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<b>Search Notes</b>  	Application/Control No.  10750568	Applicant(s)/Patent Under Reexamination  NGUYEN ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
307/64-66; 320/\$ (no search) (consulted Adolf Berhane)	06/22/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	11/01/2006	HK
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